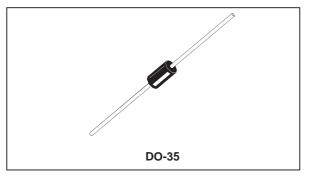


# **BAT41**

# SMALL SIGNAL SCHOTTKY DIODE

#### DESCRIPTION

General purpose metal to silicon diode featuring very low turn-on voltage and fast switching. This device has integrated protection against excessive voltage such as electrostatic discharges.



#### **ABSOLUTE RATINGS** (limiting values)

Symbol	Parameter	Value	Unit		
V <sub>RRM</sub>	Repetitive Peak Reverse Voltage	100	V		
١ <sub>F</sub>	Forward Continuous Current*	100	mA		
I <sub>FRM</sub>	Repetitive Peak Forward Current*	$\begin{array}{l} t_p \ \leq 1s \\ \delta \leq 0.5 \end{array}$	350	mA	
I <sub>FSM</sub>	Surge non Repetitive Forward Current*	$t_p \leq 10ms$	750	mA	
P <sub>tot</sub>	Power Dissipation*	$T_a = 95^{\circ}C$	100	mW	
T <sub>stg</sub> Tj	Storage and Junction Temperature Range		- 65 to +150 - 65 to +125	°C ℃	
TL	Maximum Lead Temperature for Soldering du from Case	230	°C		

#### THERMAL RESISTANCE

Symbol	Test Conditions	Value	Unit
R <sub>th(j-a)</sub>	Junction-ambient*	300	°C/W

## **ELECTRICAL CHARACTERISTICS**

# STATIC CHARACTERISTICS

Symbol	Test Conditions			Min.	Тур.	Max.	Unit
V <sub>BR</sub>	T <sub>j</sub> = 25°C	I <sub>R</sub> = 100μA		100			V
V <sub>F</sub> * *	T <sub>j</sub> = 25°C	$I_F = 1 m A$			0.4	0.45	V
	T <sub>j</sub> = 25°C	I <sub>F</sub> = 200mA				1	
I <sub>R</sub> * *	T <sub>j</sub> = 25°C		V <sub>R</sub> = 50V			0.1	μA
	T <sub>j</sub> = 100°C					20	

# DYNAMIC CHARACTERISTICS

Symbol	Test Conditions		Min.	Тур.	Max.	Unit	
С	$T_j = 25^{\circ}C$	$V_R = 1V$	f = 1MHz		2		pF

\* On infinite heatsink with 4mm lead length \* \* Pulse test:  $t_p \! \leq \! 300 \mu s \;\; \delta \! < \! 2\%$  .

#### October 2001 - Ed: 1B

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10<sup>3</sup>

10

1

10<sup>-1</sup>

10<sup>-2</sup>

0

0.2

I<sub>f</sub> (mA)

Fig. 1: Forward current versus forward voltage at different temperatures (typical values).

ture.

0.4 0.6 0.8

I<sub>Π</sub> (μΑ) 10<sup>2</sup> 90 % confidence V<sub>R</sub> = 50 V

10<sup>2</sup>

⊊Ťi

¯τ<sub>i</sub> =

= <u>∑</u> T<sub>j</sub> =

1

125°C

25°C

55°C

(V) ٧<sub>F</sub>

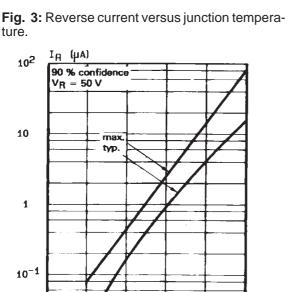
1.2 1.4

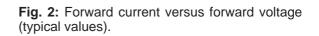
(°C) T<sub>i</sub>

125

100

75





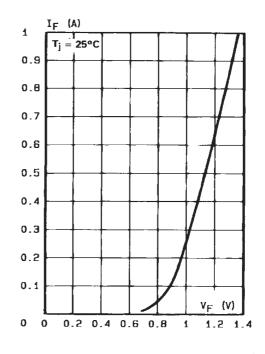
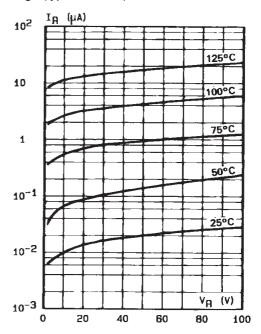


Fig. 4: Reverse current versus continuous reverse voltage (typical values).



57

10~2

0

25

50

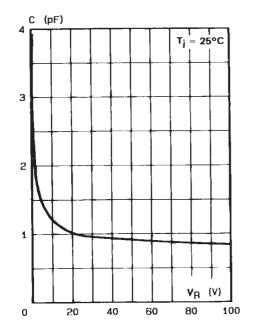
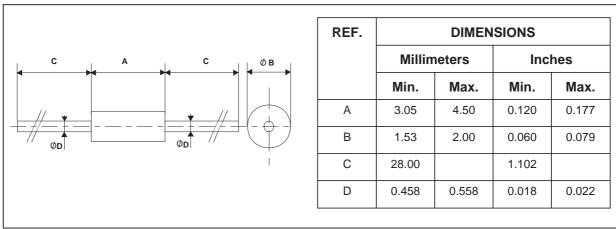


Fig. 5: Capacitance C versus reverse applied voltage  $V_{_{\rm R}}$  (typical values).



### PACKAGE MECHANICAL DATA

DO-35



Cooling method : by convection and conduction Marking: clear, ring at cathode end. Weight: 0.15g

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